

Application/Control No.	Applicant(s)/Patent under Reexamination
10/052,744	RAPP ET AL.
Examiner	Art Unit
Karen C. Tang	2151

SEARCHED					
Class	Subclass	Date	Examiner		
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
See East Search Notes	11/14/2005	кт		
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